

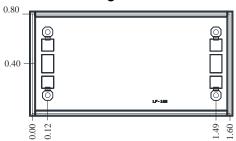
Electrical Specifications (TA=+25°C)

Parameter	Min.	Тур.	Max.	Unit
Cut-off Freq. (f ₀)	-	2	-	GHz
Insertion Loss @ f₀	-	=	1.5	dB
Return Loss	20	-	-	dB
Out of band	≥20@2.95GHz			dB
Attenuation	≥40@3.3GHz			dB

Max. Input Power: 30dBm

Operating Temperature: $-55^{\circ}\text{C} \sim +125^{\circ}\text{C}$ Storage Temperature: $-65^{\circ}\text{C} \sim +150^{\circ}\text{C}$

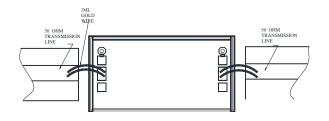
Outline Drawing



Notes:

- 1. Dimensions are in millimeters. Tolerance: ±0.05 mm
- 2. Die thickness is 0.1 mm
- 3. Typical bond pad size is 0.1 x 0.1 mm

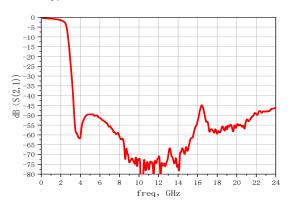
Recommended Assembly Diagram



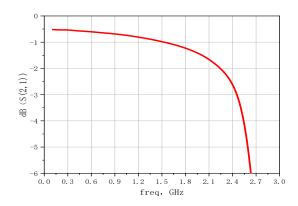
Notes:

- 1. Die is back-metallized and can be mounted with AuSn eutectic preform or with electrically conductive epoxy.
- 2. We recommend using Φ 25um Au wire for wire-bonding, with max wire length of 400um.
- 3. Sinter using AuSn (80/20) alloy, ensuring the temperature does not exceed 300 $^{\circ}\text{C}$ for a maximum of 30 seconds.

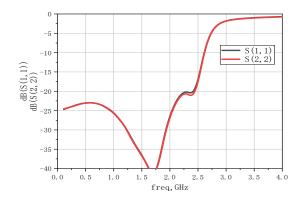
Typical Wideband Insertion Loss at T_A=25



Typical Insertion Loss at $T_A=25$



Typical Return Loss at T_A=25



- 4. Handle die in clean environment. Do not attempt to clean the chip using liquid cleaning systems.
- 5. Die is ESD sensitive. ESD protection is required during usage and storage.